## Technical University of Denmark



## Macroscale SERS Uniformity and Reproducibility Using Densely Clustered Nanopillars

Wu, Kaiyu; Schmidt, Michael Stenbæk; Rindzevicius, Tomas; Thilsted, Anil Haraksingh; Boisen, Anja

*Publication date:* 2016

Document Version Peer reviewed version

Link back to DTU Orbit

Citation (APA):

Wu, K., Schmidt, M. S., Rindzevicius, T., Thilsted, A. H., & Boisen, A. (2016). Macroscale SERS Uniformity and Reproducibility Using Densely Clustered Nanopillars. Abstract from 43rd Annual North American Meeting of the Federation of Analytical Chemistry and Spectroscopy Societies, Minneapolis, United States.

## DTU Library Technical Information Center of Denmark

#### **General rights**

Copyright and moral rights for the publications made accessible in the public portal are retained by the authors and/or other copyright owners and it is a condition of accessing publications that users recognise and abide by the legal requirements associated with these rights.

• Users may download and print one copy of any publication from the public portal for the purpose of private study or research.

- You may not further distribute the material or use it for any profit-making activity or commercial gain
- You may freely distribute the URL identifying the publication in the public portal

If you believe that this document breaches copyright please contact us providing details, and we will remove access to the work immediately and investigate your claim.

# Macroscale SERS Uniformity and Reproducibility Using Densely Clustered Nanopillars

<u>Kaiyu Wu</u><sup>1\*</sup>, Michael Stenbæk Schmidt<sup>1</sup>, Tomas Rindzevicius<sup>1</sup>, Anil Haraksingh Thilsted<sup>1</sup> and Anja Boisen<sup>1</sup> <sup>1</sup>Technical University of Denmark, Department of Micro- and Nanotechnology, Ørsteds Plads, Building 345B, 2800 Kgs. Lyngby, Denmark

\*Email address: kaiwu@nanotech.dtu.dk

The ideal surface-enhanced Raman spectroscopy (SERS) substrate should fulfil the following: i) predictable SERS enhancement, ii) macroscale SERS signal uniformity, and iii) suitability for mass production with excellent reproducibility. We have previously shown that SERS-active nanopillar structures (NPs), fabricated by lithography-free processes, show high average SERS enhancements (>10<sup>8</sup>) and are mass producible <sup>[1-3]</sup>. Here we report an improved process and show that these structures exhibit unrivalled macroscale SERS uniformities (RSD: ~2.5% in mm scale, ~7% in inch scale) and SERS reproducibilities (RSD: ~1.5% across three wafers), while at the same time obtaining a very large average enhancement factor of >10<sup>8</sup>. We also show a simple example of fast and reliable SERS analysis of low-volume analytes using such structures. We emphasize that the nanofabrication process is cost-effective, and is suitable for mass production in standard IC foundries using even larger silicon wafers.

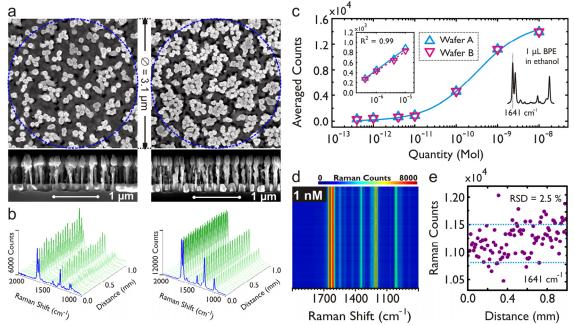


Figure 1. (a) SEM images of the low-density (left) and high-density (right) NPs. The dotted blue circles represent the area of the laser spot for probing SERS signals. (b) The scanned SERS spectra across a 1 mm line of  $10^{-9}$  M BPE on low-density (left) and high-density (right) samples of NPs, corresponding to (a). (c). Quantitative SERS analyses of BPE on two wafers. 100 data points were used for the quantification. (d) Scanned spectra and (e) data points used in (c), for the  $10^{-9}$  M measurement on wafer A.

### **References:**

1. Schmidt, M. S.; Hübner, J.; Boisen, A. Adv Mater 2012, 24(10), OP11.

2. Wu, K.; Rindzevicius, T.; Schmidt, M. S.; Mogensen, K. B.; Hakonen, A.; Boisen, A. *J Phys Chem C* **2015**, *119*, 2053.

3. Wu, K.; Rindzevicius, T.; Schmidt, M. S.; Mogensen, K. B.; Xiao, S.; Boisen, A. Opt Express 2015, 23(10), 12965